

TA Technology (Shanghai) Co., Ltd.

Test Report

No. RZA2008-1085FCC

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**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz $\pm$ 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	39.6 $\pm$ 6 %	1.43 mho/m $\pm$ 6 %
Head TSL temperature during test	(21.3 $\pm$ 0.2) °C	—	—

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	9.45 mW / g
SAR normalized	normalized to 1W	37.8 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	36.4 mW / g $\pm$ 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	4.98 mW / g
SAR normalized	normalized to 1W	19.9 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	19.5 mW / g $\pm$ 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.0 ± 6 %	1.55 mho/m ± 6 %
Body TSL temperature during test	(21.3 ± 0.2) °C	---	---

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	9.63 mW / g
SAR normalized	normalized to 1W	38.5 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	36.8 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	5.21 mW / g
SAR normalized	normalized to 1W	20.8 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	20.2 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	$52.5 \Omega + 3.3 j\Omega$
Return Loss	- 27.9 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	$48.5 \Omega + 2.9 j\Omega$
Return Loss	- 29.6 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.203 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	June 4, 2002

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DASY4 Validation Report for Head TSL

Date/Time: 21.03.2008 15:30:20

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB;

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.43$ mho/m; $\epsilon_r = 39.6$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ET3DV6 - SN1507 (HF); ConvF(4.97, 4.97, 4.97); Calibrated: 11.09.2007
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 15.01.2008
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

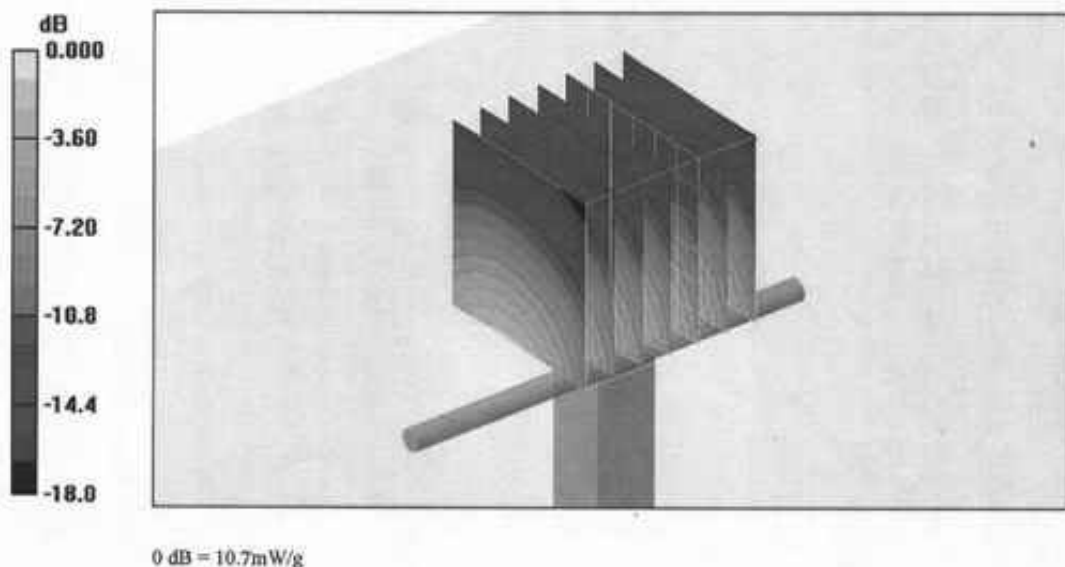
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 87.8 V/m; Power Drift = 0.057 dB

Peak SAR (extrapolated) = 16.2 W/kg

SAR(1 g) = 9.45 mW/g; SAR(10 g) = 4.98 mW/g

Maximum value of SAR (measured) = 10.7 mW/g

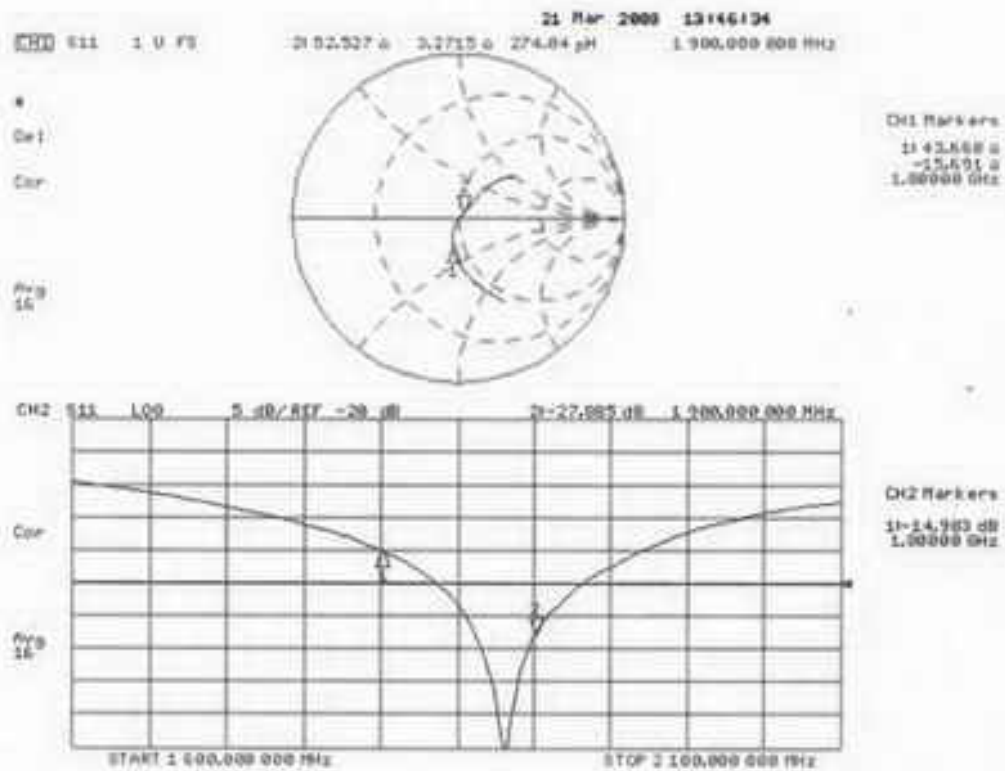


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Impedance Measurement Plot for Head TSL



DASY4 Validation Report for Body TSL

Date/Time: 21.03.2008 16:41:02

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: MSL U10 BB;

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.55$ mho/m; $\epsilon_r = 52$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ET3DV6 - SN1507 (HF); ConvF(4.43, 4.43, 4.43); Calibrated: 11.09.2007
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 15.01.2008
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

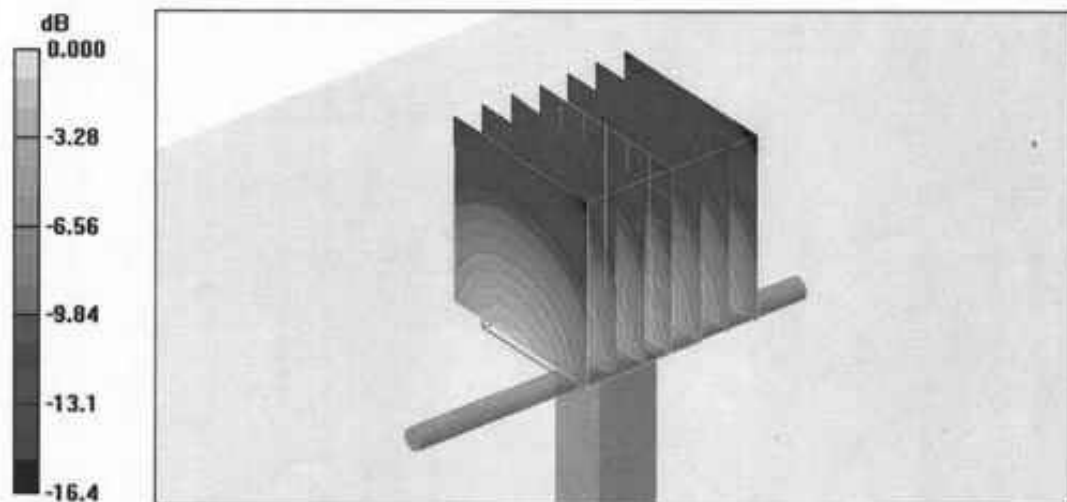
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 89.2 V/m; Power Drift = 0.021 dB

Peak SAR (extrapolated) = 16.1 W/kg

SAR(1 g) = 9.63 mW/g; SAR(10 g) = 5.21 mW/g

Maximum value of SAR (measured) = 11.3 mW/g



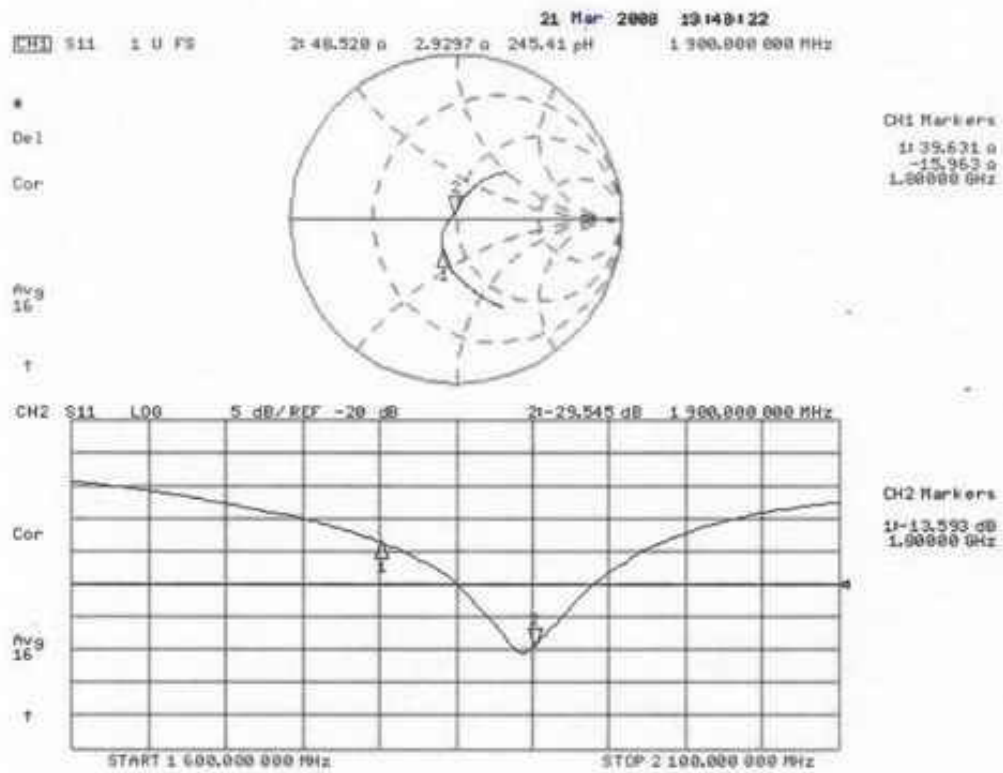
0 dB = 11.3mW/g

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Impedance Measurement Plot for Body TSL



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ANNEX G: DAE4 CALIBRATION CERTIFICATE

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Accreditation No.: SCS 108

Client TA (Auden)

Certificate No: DAE4-452_Jul08

CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BA - SN: 452

Calibration procedure(s) QA CAL-06.v12
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: July 21, 2008

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	04-Oct-07 (No: 6467)	Oct-08
Keithley Multimeter Type 2001	SN: 0810278	03-Oct-07 (No: 6465)	Oct-08
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	06-Jun-08 (in house check)	In house check: Jun-09

Calibrated by: Name Andrea Guntli Function Technician Signature

Approved by: Fin Bornholt R&D Director

Issued: July 21, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-452_Jul08

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